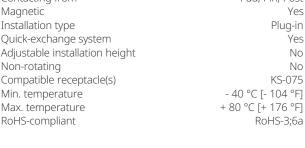
Spring-loaded test probe GKS-075 214 064 A 2800 Item GKS-075-0043



- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures

General data

Product aroup ICT / FCT (in-circuit test and function test Sub-product group Standard stroke test probe Series GKS-075 Grid 1.91 mm [75 mil] Contacting from Pad, Pin, Post Magnetic Yes Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No KS-075 Compatible receptacle(s) - 40 °C [- 104 °F] Min. temperature Max. temperature + 80 °C [+ 176 °F]

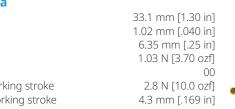


Electrical data

Current load capacity / rated current 3 A Typical resistance (Ri) <20 mOhm

Mechanical data

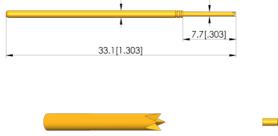
Total length Barrel diameter Maximum stroke Spring pre-load Collar height Spring force at working stroke Recommended working stroke



Tip style data

Tip style 14 4-point crown, self-cleaning Tip diameter 0.64 mm [.025 in] Tip style surface A gold 2 steel Tip style material



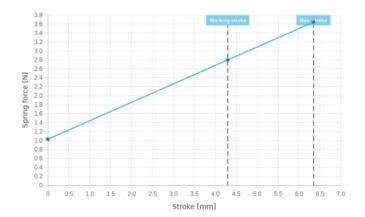




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INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com













Learn more about ICT/FCT Test probes

